

ST2329A

2-bit dual supply level translator without direction control pin

Features

- 18 Mbps (max) data rate when driven by a totem pole driver
- 6.8 Mbps (max) data rate when driven by an open drain pole driver
- Bidirectional level translation without direction control pin
- Wide V_L voltage range of 1.65 to 3.6 V
- Wide V_{CC} voltage range of 1.80 to 5.5 V
- Power down mode feature when either supply is off, all I/Os are in high impedance
- Low quiescent current (max 4 µA)
- Able to be driven by totem pole and open drain drivers
- 5.5 V tolerant enable pin
- ESD performance on all pins: ±2 kV HBM
- Small package and footprint: QFN10L (1.8 x 1.4 mm) package

Applications

- Low voltage system level translation
- Mobile phones and other mobile devices
- I²C level translation
- UART level translation



Description

The ST2329A is a 2-bit dual supply level translator which provides the level shifting capability to allow data transfer in a multi-voltage system. Externally applied voltages, V_{CC} and V_L , set the logic levels on either side of the device. It utilizes transmission gate-based design that allows bidirectional level translation without a control pin.

The ST2329A accepts a V_L from 1.65 to 3.6 V and V_{CC} from 1.80 to 5.5 V, making it ideal for data transfer between low-voltage ASICs/PLD and higher voltage systems. This device has a tristate output mode which can be used to disable all I/Os.

The ST2329A supports power down mode when V_{CC} is grounded/floating and the device is disabled via the OE pin.

Table 1. Device summary

Order code	Package	Packaging
ST2329AQTR	QFN10 (1.8 x 1.4 mm)	Tape and reel (3000 parts per reel)

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1 Pin settings

1.1 Pin connection

Figure 1. Pin connection (top through view)



1.2 Pin description

Pin number	Symbol	Name and function
1	I/O _{VL1}	Data input/output
2	I/O _{VL2}	Data input/output
3	OE	Output enable
4	NC	No connection
5	NC	No connection
6	GND	Ground
7	I/O _{VCC2}	Data input/output
8	I/O _{VCC1}	Data input/output
9	V _{CC}	Supply voltage
10	VL	Supply voltage

Table 2. Pin description



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2 Device block diagrams





Figure 3. Application block diagram



3 Supplementary notes

3.1 Driver requirement

The ST2329A may be driven by an open drain or totem pole driver and the nature of the device's output is "open drain". It must not be used to drive a pull-down resistor since the impedance of the output at HIGH state depends on the pull-up resistor placed at the I/Os.

As the device has pull-up resistors on both the I/O_{VCC} and I/O_{VL} ports, the user needs to ensure that the driver is able to sink the required amount of current. For example, if the settings are V_{CC} = 5.5 V, V_L = 4.3 V and the pull-up resistor is 10 kΩ then the driver must be able to sink at least (5.5 V/10 kΩ) + (4.3 V /10 kΩ) = 1 mA and still meet the V_{IL} requirements of the ST2329A.

3.2 Load driving capability

To support the open drain system, the one-shot transistor is turned on only during high transition at the output side. When it drives a high state, after the one-shot transistor is turned off, only the pull-up resistor is able to maintain the state. In this case, the resistive load is not recommended.

3.3 Power off feature

In some applications where it might be required to turn off one of the power supplies powering up the level translator, the user may turn off the V_{CC} only when the OE pin is low (device is disabled). There will be no current consumption in V_L due to floating gates or other causes, and the I/Os are in a high-impedance state in this mode.

3.4 Truth table

Table	3.	Truth	table

Enable	Bidirectional Input/Output						
OE	I/O _{VCC}	I/O _{VL}					
H ⁽¹⁾	H ⁽²⁾	H ⁽¹⁾					
H ⁽¹⁾	L	L					
L	Z ⁽³⁾	Z ⁽³⁾					

1. High level V_L power supply referred

2. High level V_{CC} power supply referred

3. Z = high impedance



4 Maximum rating

Stressing the device above the rating listed in the "Absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only, and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Symbol	Parameter	Value	Unit
VL	Supply voltage	-0.3 to 4.6	V
V _{CC}	Supply voltage	-0.3 to 6.5	V
V _{OE}	DC control input voltage	-0.3 to 6.5	V
V _{I/OVL}	DC I/O _{VL} input voltage (OE = GND or V_L)	-0.3 to V _L + 0.3	V
V _{I/OVCC}	DC I/O _{VCC} input voltage (OE = GND or V_L)	-0.3 to V _{CC} + 0.3	V
I _{IK}	DC input diode current	-20	mA
I _{I/OVL}	DC output current	±25	mA
II/OVCC	DC output current	±258	mA
I _{SCTOUT}	Short circuit duration, continuous	40	mA
PD	Power dissipation ⁽¹⁾	500	mW
T _{STG}	Storage temperature	-65 to 150	°C
TL	Lead temperature (10 seconds)	300	°C
ESD	Electrostatic discharge protection (HBM)	±2	kV

Table 4. Absolute maximum ratings

1. 500 mW: 65 $^{\circ}$ C derated to 300 mW by 10W/ $^{\circ}$ C: 65 $^{\circ}$ C to 85 $^{\circ}$ C

4.1 Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Min	Тур	Max	Unit
VL	Supply voltage	1.65	_	3.6	V
V _{CC} ⁽¹⁾	Supply voltage	1.8	_	5.5	V
V _{OE}	Input voltage (OE output enable pin, V _L power supply referred)	0	_	3.6	V
VI/O _{VL}	I/O _{VL} voltage	0	_	VL	V
V _I /O _{VCC}	I/O _{VCC} voltage	0	_	V _{CC}	V
T _{op}	Operating temperature	-40	_	85	°C
dt/dV	Input rise and fall time	0	_	1	ns/V

1. V_{CC} must be greater than V_L .



5 Electrical characteristics

5.1 DC characteristics

Over recommended operating conditions unless otherwise noted. All typical values are at T_{A} = 25 $^{o}\text{C}.$

Table 6.	DC characteristics	

							Value			
Symbol	Parameter	VL	v _{cc}	Test conditions	ТА	= 25 °C	;	-40 to 8	35 °C	Unit
					Min	Тур	Max	Min	Max	
		1.65			1.4	_	_	1.4	-	
		2.0			1.6	_	_	1.6	_	
V _{IHL}	High level input voltage (I/O _{VL})	2.5	V_L to 5.5	-	2.0	_	-	2.0	-	V
		3.0			2.4	_	_	2.4	_	
		3.6			2.8	_	-	2.8	-	
		1.65			_	_	0.3	-	0.3	
		2.0			_	_	0.4	-	0.4	
V _{ILL}	Low level input voltage (I/O _{VI})	2.5	V_L to 5.5		_	_	0.5	-	0.5	
		3.0			_	_	0.6	_	0.6	
		3.6			_	_	0.8	-	0.8	
		1.8		1.6	_	_	1.6	_		
			2.5		2.3	-	_	2.3	_	v
M	High level input voltage	1.65 to	3.0		2.7	-	-	2.7	-	
V _{IHC}	(I/O _{VCC})	V _{CC}	3.6		3.3	-	_	3.3	-	v
			4.3		3.5	-	_	3.5	-	1
			5.5		4.2	_	_	4.2	-	
V	Low level input voltage	1.65 - 2.5	3 - 5.5	-	_	_	-	0.3	-	v
V _{ILC}	(I/O _{VCC})	2.7 - 3.6	3.6 - 5.5	-	_	_	_	0.5	-	v
		1.65			1.0	-	-	1.0	-	
		2.0	1		1.2	_	-	1.2	-	1
V _{IH-OE}	High level input voltage (OE)	2.5	V_L to 5.5	-	1.4	_	-	1.4	_	V
		3.0]		1.6	_	_	1.6	_]
		3.6			2.0	-	-	2.0	_	



							Value			
Symbol	Parameter	VL	v _{cc}	Test conditions	TA	= 25 °C	;	-40 to 8	85 °C	Unit
					Min	Тур	Max	Min	Max	
		1.65			—	—	0.33	_	0.33	
		2.0			_	_	0.40	Ι	0.40	
V _{IL-OE}	Low level input voltage (OE)	2.5	V_L to 5.5		_	-	0.50		0.50	V
		3.0			_	-	0.60		0.60	
		3.6			_	-	0.75		0.75	
V _{OLL}	Low level output voltage (I/O _{VL})	1.65 to 3.6	V_L to 5.5	$\begin{array}{l} \text{IO} = 1.0 \text{ mA} \\ \text{I/O}_{\text{VCC}} \leq 0.15 \text{ V} \end{array}$	_	_	0.40	_	0.40	v
V _{OLC}	Low level output voltage (I/O _{VCC})	1.65 to 3.6	V_L to 5.5	$\begin{array}{l} \text{IO} = 1.0 \text{ mA} \\ \text{I/O}_{\text{VL}} &\leq 0.15 \text{ V} \end{array}$	_	_	0.40	_	0.40	v
I _{OE}	Control input leakage current (OE)	1.65 to 3.6	V_L to 5.5	V _{OE} = GND or V _L	_	_	±0.1	_	±0.1	μA
I _{IO_LKG}	High impedance leakage current (I/O _{VL} , I/O _{VCC})	1.65 to 3.6	V _L to 5.5	OE = GND	_	_	±0.1	_	±0.1	μΑ
Ιανοο	Quiescent supply current V _{CC}	1.65 to 3.6	V_L to 5.5	Only pull-up resistor connected to I/O	_	3	3.5	_	4	μA
I _{QVL}	Quiescent supply current V _L	1.65 to 3.6	V_L to 5.5	only pull-up resistor connected to I/O	_	0.01	0.1	_	1	μA
Iz-vcc	High impedance quiescent supply current V _{CC}	1.65 to 3.6	V_L to 5.5	OE = GND; only pull-up resistor connected to I/O	_	3	3.5	_	4	μΑ
I _{Z-VL}	High impedance quiescent supply current V _L	1.65 to 3.6	V_L to 5.5	OE = GND; only pull-up resistor connected to I/O	_	0.01	0.1	_	1	μΑ

 Table 6.
 DC characteristics (continued)



5.2 AC characteristics

5.2.1 Device driven by open drain driver

Load C_L = 15 pF; R_{up} = 4.7 kΩ; driver $t_r = t_f \le 2$ ns over temperature range -40 °C to 85 °C.

Symbol	Parameter		V _{CC} = 1.8 –2.5 V		$V_{CC} = 2.7 - 3.6 V$		V _{CC} = 4.3 – 5.5 V		Unit
			Min	Max	Min	Max	Min	Max	
^t RVCC	Rise time I/O _{VCC}		_	80.0	—	60.0	—	45.0	ns
^t FVCC	Fall time I/O _{VCC}		_	23.2	_	33.9	_	53.3	ns
t _{RVL}	Rise time I/O _{VL}		_	60.0	_	45.0	_	35.0	ns
t _{FVL}	Fall time I/O _{VL}		-	16.4	—	17.6	-	16.9	ns
	Propagation delay time	t _{PLH}	-	3.4	-	2.0	-	2.0	ns
tl/OVL-VCC	I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}	t _{PHL}	_	13.9	_	19.1	_	30.2	ns
	Propagation delay time	t _{PLH}	-	2.0	-	2.0	-	2.6	ns
^t I/OVCC-VL	I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-LH}	t _{PHL}	1	8.6	_	9.0	5.5 V Min I - 2 - 5 - 5 - 2 - 5 - 5 - 5 - 2 - 5 - 5 - 2 - 5 - 5 - 5 - 5 - 5 - 5 - 5 - 5	9.5	ns
t _{PZL} t _{PZH}	Output enable and	En	-	10	_	10	-	10	ns
t _{PLZ} t _{PHZ}			_	40	_	40	_	40	ns
D _R	Data rate ⁽¹⁾		_	1.8	_	2.2	_	3.4	MHz

Table 7. AC characteristics - test conditions: $V_L = 1.65 - 1.8 V$

The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.

Symbol	Parameter	V _{CC} = 2.7	-3.6 V	V _{CC} = 4.	Unit		
Symbol	Farameter	Min	Max	Min	Max	Unit	
t _{RVCC}	Rise time I/O _{VCC}		—	70.0	_	50.0	ns
t _{FVCC}	Fall time I/O _{VCC}		_	14.8	-	19.1	ns
t _{RVL}	Rise time I/O _{VL}		_	50.0	_	35.0	ns
t _{FVL}	Fall time I/O _{VL}	Fall time I/O _{VL}		9.8	_	10.0	ns
	Propagation delay time	t _{PLH}	_	2.0	_	2.0	ns
^t I/OVL-VCC	I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}	t _{PHL}	_	8.2	_	11.6	ns
	Propagation delay time	t _{PLH}	_	2.0	_	2.0	ns
^t I/OVCC-VL	I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-LH}	t _{PHL}	_	5.3	_	5.9	ns

Table 8.	AC characteristics - test conditions: $V_L = 2.5 - 2.7 V$
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Symbol	Parameter		V _{CC} = 2.7	-3.6 V	V _{CC} = 4.3	3 – 5.5 V	Unit
Symbol	Farameter	Parameter		Max	Min	Max	Unit
t _{PZL} t _{PZH}	Output enable and	En	—	6	—	6	ns
t _{PLZ} t _{PHZ}		Dis	_	40	_	40	ns
D _R	Data rate ⁽¹⁾		_	2.2	_	3.0	MHz

Table 8.AC characteristics - test conditions: VL = 2.5 – 2.7 V (continued)

1. The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.

Table 9. AC characteristics - test conditions: $V_L = 2.7 - 3.6 V$

Symbol Parameter			V _{CC} = 4.3	3 – 5.5 V	Unit
Symbol	Parameter	Min	Max	Unit	
t _{RVCC}	Rise time I/O _{VCC}		—	55.0	ns
t _{FVCC}	Fall time I/O _{VCC}		_	17.2	ns
t _{RVL}	Rise time I/O _{VL}		_	40.0	ns
t _{FVL}	Fall time I/O _{VL}	_	9.7	ns	
	Propagation delay time	t _{PLH}	—	2.0	ns
ti/OVL-VCC	I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}	t _{PHL}	_	10.6	ns
	Propagation delay time	^t PLH	_	2.0	ns
^t I/OVCC-VL	I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	t _{PHL}	_	4.8	ns
^t PZL ^t PZH		En	-	6	ns
t _{PLZ} t _{PHZ}	Output enable and disable time	Dis	-	40	ns
D _R	Data rate ⁽¹⁾	_	_	3.0	MHz

1. The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.

5.2.2 Device driven by totem pole driver

Load C_L = 15 pF; R_{up} = 10 kΩ; driver $t_r\!=\!t_f$ \leq 2 ns over temperature range -40 °C to 85 °C

Table 10. AC characteristics - test conditions: $V_L = 1.65 - 1.8$	V
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Symbol	Parameter				$V_{CCB} = 2.7 - 3.6 V$		$V_{CCB} = 4.3 - 5.5 V$		Unit
Symbol			Min	Max	Min	Max	Min	Max	Onit
t _{RVCC}	Rise time I/O _{VCC}		_	7.2	—	4.6	—	1.4	ns
t _{FVCC}	Fall time I/O _{VCC}		_	23.2	-	33.9	-	53.3	ns
t _{RVL}	Rise time I/O _{VL}		_	5.9	-	5.7	-	5.5	ns
t _{FVL}	Fall time I/O _{VL}		_	16.4	-	17.6	—	16.9	ns



	able 10. AC characteristics - test conditions. $v_{L} = 1.05 - 1.0$ v								
t _{I/OVL} -	Propagation delay time	t _{PLH}	—	5.5	—	4.1		3.6	ns
VCC	t _{PHL}	_	13.9	_	19.1		30.2	ns	
tuovoo	Propagation delay time	t _{PLH}	_	4.5	_	3.9		3.6	ns
ti/OVCC- VL I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	t _{PHL}	_	8.6	_	9.0		9.5	ns	
t _{PZL} t _{PZH}	Output enable and	En	_	10	_	10	—	10	ns
t _{PLZ} t _{PHZ} disable	disable time	Dis	_	40	_	40	_	40	ns
D _R	Data rate ⁽¹⁾		—	6.4	—	4.5	_	3.0	MHz

Table 10. AC characteristics - test conditions: $V_L = 1.65 - 1.8 V$

1. The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.



Symbol	Deremeter		V_{CC} = 2.7 -3.6 V		V _{CC} = 4.	11	
Symbol	Parameter		Min	Мах	Min	Мах	Unit
t _{RVCC}	Rise time I/O _{VCC}		-	3.8	—	2.8	ns
^t FVCC	Fall time I/O _{VCC}		_	14.8	_	19.1	ns
t _{RVL}	Rise time I/O _{VL}		_	3.3	_	3.2	ns
t _{FVL}	Fall time I/O _{VL}		_	9.8	_	10.0	ns
	Propagation delay time	t _{PLH}	-	3.2	_	2.8	
t _{I/OVL-VCC} I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	t _{PHL}	_	8.2	_	11.6	ns	
		+	_	2.6	_	2.0	ns
t	Propagation delay time	t _{PLH}		2.0	_	2.0	ns
^t I/OVCC-VL	I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	t		5.3		5.9	ns
		t _{PHL}	_	0.0	_	5.9	ns
t _{PZL} t _{PZH}	Output enable and	En	_	6	_	6	ns
^t PLZ ^t PHZ	disable time	Dis	_	40	-	40	ns
D _R	Data rate ⁽¹⁾	-	-	9	—	6.8	MHz

Table 11. AC characteristics - test conditions: $V_L = 2.5 - 2.7 V$

1. The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.

Table 12. AC characteristics - test conditions: $V_L = 2.7 - 3.6 V$

Symbol	Devemeter		V _{CC} = 4	.3 –5.5 V	Unit
Symbol	Parameter	Parameter		Max	Unit
t _{RVCC}	Rise time I/O _{VCC}		-	2.9	ns
t _{FVCC}	Fall time I/O _{VCC}		-	17.2	ns
t _{RVL}	Rise time I/O _{VL}		-	3.0	ns
t _{FVL}	Fall time I/O _{VL}		-	9.7	ns
	Propagation delay time	t _{PLH}	-	2.7	ns
ti/OVL-VCC	t _{I/OVL-VCC} I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}	t _{PHL}	-	10.6	ns
		t		1.9	ns
t	Propagation delay time	t _{PLH} —	1.5	ns	
ti/ovcc-vL	I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	+		4.8	ns
	VOOTILE VETILE	t _{PHL}			ns
t _{PZL} t _{PZH}	Output enable and disable	En	-	6	ns
^t PLZ ^t PHZ	t _{PLZ} t _{PHZ} time		-	40	ns
D _R	Data rate ⁽¹⁾	•	-	7.2	MHz

1. The data rate is guaranteed based on the condition that the output I/O signal rise/fall time is less than 15% of the input I/O signal period; the input I/O signal is at 50% duty cycle and the output I/O signal duty cycle deviation not less than 30%.







Table 13. Test circuit switches

Test	Switch				
1631	Driving I/O _{VL}	Driving I/O _{VCC}	Open drain driving		
t _{PLH} , t _{PHL}	Open	Open	Open		



6 Waveforms

	Driving	g I/O _{VL}	Driving I/O _{VCC}		
Symbol	1.8 V \leq V_L \leq V_CC \leq 2.5 V	$\begin{array}{l} \textbf{3.3 V} \hspace{0.1 cm} \leq \hspace{-0.1 cm} \textbf{V}_{L} \hspace{-0.1 cm} \leq \hspace{-0.1 cm} \textbf{V}_{CC} \hspace{0.1 cm} \leq \hspace{-0.1 cm} \\ \textbf{5.0 V} \end{array}$	1.8 V \leq V_L \leq V_CC \leq 2.5 V	$\begin{array}{c} \textbf{3.3V} \leq \textbf{V}_{L} \leq \textbf{V}_{CC} \\ \textbf{5.0 V} \end{array}$	
V _{IH}	VL	VL	V _{CC}	V _{CC}	
V _{IM}	50% V _L	50% V _L	50% V _{CC}	50% V _{CC}	
V _{OM}	50% V _{CC}	50% V _{CC}	50% V _L	50% V _L	
V _X	V _{OL} +0.15V	V _{OL} +0.3V	V _{OL} +0.15V	V _{OL} +0.3V	
V _Y	V _{OH} -0.15V	V _{OH} -0.3V	V _{OH} -0.15V	V _{OH} -0.3V	

Table 14.Waveform symbol value









Figure 6. Waveform - output enable and disable time (f = 1 MHz; 50% duty cycle)



7 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.





Doc ID 14907 Rev 2



Symbol	Millimeters					
	Тур	Min	Мах			
А	0.50	0.45	0.55			
A1	0.02	0	0.05			
A3	0.127					
b	0.20	0.15	0.25			
D	1.80	1.75	1.85			
E	1.40	1.35	1.45			
е	0.40					
L	0.40	0.35	0.45			

 Table 15.
 Mechanical data for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.40 mm pitch







Figure 9. Carrier tape for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.40 mm pitch

Figure 10. Reel information for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.40 mm pitch







Figure 11. Reel information for QFN10 (1.8 x 1.4 x 0.5 mm) - 0.40 mm pitch



8 Revision history

Table 16.	Document revision history
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Date	Revision	Changes
16-Jul-2008	1	Initial release.
22-Jun-2009	2	Document status promoted from Preliminary data to datasheet. Updated: Features section and <i>Chapter 5: Electrical characteristics</i> . Modified: <i>Section 7</i> .



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